

DESCRIPTION

The ADM202 device consists of two line drivers, two line receivers, and a dual chargepump circuit with±15-kV ESD protection pin to pin (serial-port connection pins, including GND).

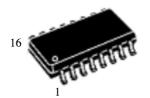
The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 5-V supply. The device operates at data signaling rates up to 120 kbit/s and a maximum of 30-V/µs driver output slew rate.

FEATURES

- ESD Protection for RS-232 Bus Pins
 ±15-kV Human-Body Model
- Meets or Exceeds the Requirements of TIA/ EIA-232-F and ITU v.28 Standards
- Operates at 5-V VCC Supply
- · Operates Up To 120 kbit/s
- External Capacitors...4 × 0.1 µF
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II ·

APPLICATIONS

- Battery -Powered System
- Notebooks
- Hand-Held devices
- Portable computer



SOP-16 (SOIC-16)

FUNCTION TABLE

Each Driver					
INPUT DIN	OUTPUT DOUT				
L	Н				
Н	L				

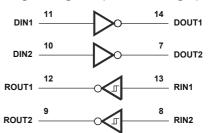
H = high level, L = low level

Each Receiver

INPUT RIN	OUTPUT ROUT
L	Н
Н	L
Open	Н

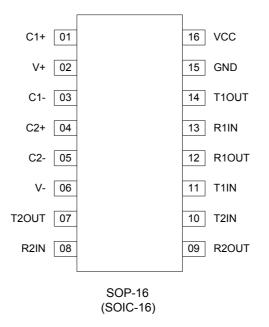
H = high level, L = low level, Open = input disconnected or connected driver off

Logic Diagram (Positive Logic)



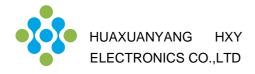


PIN CONFIGURATION



PIN DESCRIPTION

Pin No.	Pin Name	Pin Description	
1	C1+	Terminal for Positive Charge-Pump C1 Capacitor	
2	V+	Positive Voltage Generated by the Charge-Pump	
3	C1-	Terminal for Negative Charge-Pump C1 Capacitor	
4	C2+	Terminal for Positive Charge-Pump C2 Capacitor	
5	C2-	Terminal for Negative Charge-Pump C2 Capacitor	
6	V-	Negative Voltage Generated by the Charge-Pump	
7	T2OUT	RS-232 Driver Output (Levels RS-232)	
8	R2IN	RS-232 Receiver Input (Levels RS-232)	
9	R2OUT	RS-232 Receiver Output (Levels TTL/CMOS)	
10	T2IN	RS-232 Driver Input (Levels TTL/CMOS)	
11	T1IN	RS-232 Driver Input (Levels TTL/CMOS)	
12	R10UT	RS-232 Receiver Output (Levels TTL/CMOS)	
13	R1IN	RS-232 Receiver Input (Levels RS-232)	
14	T1OUT	RS-232 Driver Output (Levels RS-232)	
15	GND	Ground	
16	VCC	Supply Voltage Input	



SPECIFICATIONS

Absolute Maximum Ratings

PARAMETER	SYMBOL	MIN.	MAX.	UNIT
Supply Voltage	V _{CC}	-0.3	6.0	V
Transmitter High Output Voltage	V ₊	V _{CC} -0.3	14	V
Transmitter Low Output Voltage	V.	-0.3	-14	V
Transmitter Input Voltage	V _{TIN}	-0.3	V ₊ +0.3	V
Receiver Input Voltage	V _{RIN}	-30	30	V
Voltage Applied to Transmitter Output	V _{TOUT}	V ₋ -0.3	V ₊ +0.3	V
Voltage Applied to Receiver Output	V _{ROUT}	-0.3	V _{CC} +0.3	V
Storage Temperature Range	T _{STG}	-65	150	°C

ESD protection

PIN		TEST CONDITIONS	ТҮР	UNIT
DOI	ut, Rin	Human-Body Model	±15	kV

Recommended Operating Conditions over operating free-air temperature range (unless otherwise noted⁽¹⁾)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
	Supply voltage	4.5	5	5.5	V
V _{IH}	Driver high-level input voltage (D _{IN})	2			V
VIL	Driver low-level input voltage (D _{IN})			0.8	V
M	Driver input voltage (D _{IN})	0		5.5	V
vi	Receiver input voltage	- 30		30	V

(1) Test conditions are C1 – C4 = 0.1μ F at V_{CC} = 5V ±0.5V.

Thermal Information

SYMBOL	THERMAL METRIC	TYP	UNIT
R _{0 JA}	Junction-to-ambient thermal resistance	84.6	°C/W
R _{0 JC(top)}	Junction-to-case (top) thermal resistance	43.5	°C/W
R _{0 JB}	Junction-to-board thermal resistance	43.2	°C/W
ΨJT	Junction-to-top characterization parameter	10.4	°C/W
ψJB	Junction-to-board characterization parameter	42.8	°C/W

Electrical Characteristics

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	ТҮР(1)	MAX	UNIT
ICC	Supply current	No load, $V_{CC} = 5 V$		8	15	mA

(1) All typical values are at V_{CC} = 5 V, and T_A = 25°C.



Driver Section

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{OH}	High-level output voltage	D_{OUT} at R_L = 3k Ω to GND, D_{IN} = GND	5	9		V
V _{OL}	Low-level output voltage	D_{OUT} at R_L = 3k Ω to GND, D_{IN} = V_{CC}	- 5	- 9		V
I _{IH}	High-level input current	V _I = V _{CC}		0	200	μA
IL	Low-level input current	V _I at 0V		0	- 200	μA
I _{OS} ⁽¹⁾	Short-circuit output current	V _{CC} = 5.5V, V _O = 0V		±10	±60	mA
r _O	Output resistance	V_{CC} , V+, and V - = 0V, V_O = ±2V	300			Ω

(1) Short-circuit durations should be controlled to prevent exceeding the device absolute power-dissipation ratings, and not more than one output should be shorted at a time.

Receiver Section

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{OH}	High-level output voltage	I _{OH} = - 1mA	3.5	V_{CC} - 0.4		V
V _{OL}	Low-level output voltage	I _{OL} = 1.6mA			0.4	V
V _{IT+}	Positive-going input threshold voltage	V _{CC} = 5V, T _A = 25°C		1.7	2.4	V
V _{IT -}	Negative-going input threshold voltage	V _{CC} = 5V, T _A = 25°C	0.8	1.2		V
V _{hys}	Input hysteresis (V _{IT+} - V _{IT-})		0.2	0.5	1	V
r _i	Input resistance	$V_{I} = \pm 3V$ to $\pm 25V$	3	5	7	kΩ

SWITCHING CHARACTERISTICS

Driver Section

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	МАХ	UNIT
	Maximum data rate	C _L = 50pF to 1000pF, R _L = 3k Ω to 7k Ω one D _{OUT} switching	120			kbit/s
t _{PLH(D)}	Propagation delay time, low- to high-level output	C_L = 2500pF, R_L = 3k Ω , all drivers loaded		2		μs
t _{PHL(D)}	Propagation delay time, high- to low-level output	C_L = 2500pF, R_L = 3k Ω , all drivers loaded		2		μs
t _{sk(p)}	Pulse skew ⁽¹⁾	C _L = 150 to 2500pF, R _L = 3k Ω to 7 k Ω		300		ns
SR(tr)	Slew rate, transition region	C _L = 50 to 1000pF, R _L = 3k Ω to 7 k Ω , V _{CC} = 5V	3	6	30	V/µs

(1) Pulse skew is defined as $|t_{PLH} - t_{PHL}|$ of each channel of the same device.

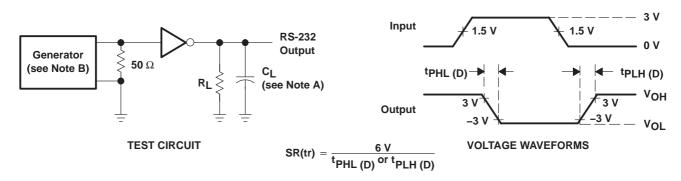
Receiver Section

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH(R)}	Propagation delay time, low- to high-level output	C _L = 150pF		0.5	10	μs
t _{PHL(R)}	Propagation delay time, high- to low-level output	C _L = 150pF		0.5	10	μs
t _{sk(p)}	Pulse skew ⁽¹⁾	C _L = 150pF		300		ns

(1) Pulse skew is defined as $|t_{PLH}\ ^-\ t_{PHL}|$ of each channel of the same device.



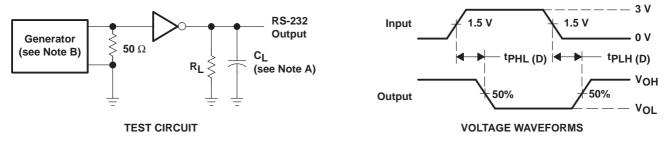
PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 120 kbit/s, $Z_0 = 50 \Omega$, 50% duty cycle, $t_f \le 10$ ns. $t_f \le 10$ ns.

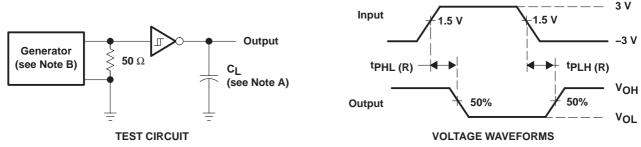
Figure 1. Driver Slew Rate



NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 120 kbit/s, $Z_0 = 50 \Omega$, 50% duty cycle, $t_f \le 10$ ns. $t_f \le 10$ ns.

Figure 2. Driver Pulse Skew



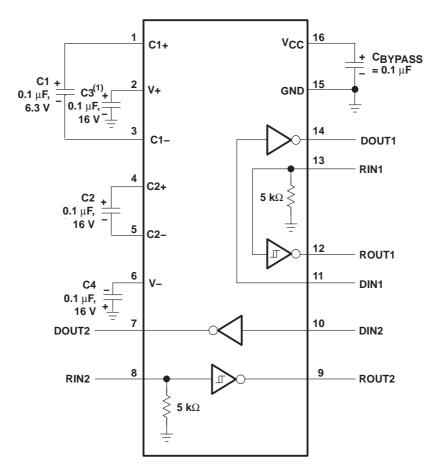
NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: $Z_{O} = 50 \Omega$, 50% duty cycle, $t_{f} \le 10$ ns. $t_{f} \le 10$ ns.

Figure 3. Receiver Propagation Delay Times



APPLICATION INFORMATION



(1) C3 can be connected to V_{CC} or GND.

- NOTES: A. Resistor values shown are nominal.
 - B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

Figure 4. Typical Operating Circuit and Capacitor Values



APPLICATION INFORMATION

Capacitor Selection

The capacitor type used for C1 through C4 is not critical for proper operation. The ADM202 requires 0.1μ F capacitors. Capacitors up to 10μ F can be used without harm. Ceramic dielectrics are suggested for the 0.1μ F capacitors. When using the minimum recommended capacitor values, make sure the capacitance value does not degrade excessively as the operating temperature varies. If in doubt, use capacitors with a larger (for example, 2×) nominal value. The capacitors' effective series resistance (ESR), which usually rises at low temperatures, influences the amount of ripple on V+ and V - .

Use larger capacitors (up to 10μ F) to reduce the output impedance at V+ and V - .

Bypass V_{CC} to ground with at least 0.1µF. In applications sensitive to power-supply noise generated by the charge pumps, decouple V_{CC} to ground with a capacitor the same size as (or larger than) the charge-pump capacitors (C1 to C4).

ESD Protection

ADM202 devices have standard ESD protection structures incorporated on all pins to protect against electrostatic discharges encountered during assembly and handling. In addition, the RS-232 bus pins (driver outputs and receiver inputs) of these devices have an extra level of ESD protection. Advanced ESD structures were designed to successfully protect these bus pins against ESD discharge of ±15kV when powered down.

ESD Test Conditions

Stringent ESD testing is performed by TI based on various conditions and procedures. Please contact TI for a reliability report that documents test setup, methodology, and results.

Human-Body Model (HBM)

The HBM of ESD testing is shown in Figure 5, Figure 6 shows the current waveform that is generated during a discharge into a low impedance. The model consists of a 100-pF capacitor, charged to the ESD voltage of concern, and subsequently discharged into the device under test (DUT) through a 1.5-k Ω resistor.

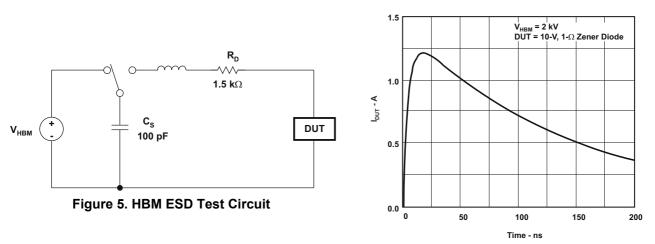


Figure 6. Typical HBM Current Waveform

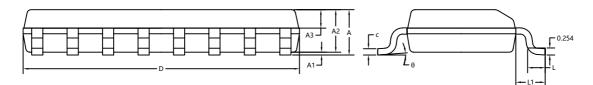
Machine Model (MM)

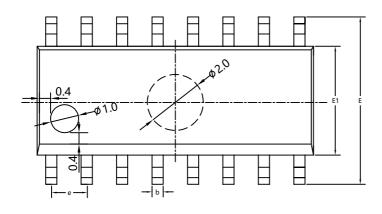
The MM ESD test applies to all pins using a 200-pF capacitor with no discharge resistance. The purpose of the MM test is to simulate possible ESD conditions that can occur during the handling and assembly processes of manufacturing. In this case, ESD protection is required for all pins, not just RS-232 pins. However, after PC board assembly, the MM test no longer is as pertinent to the RS-232 pins.



PACKAGE OUTLINE DIMENSIONS

SOP-16(SOIC-16)





SYMBOL	MILLIMETER		
	MIN	NOM	МАХ
A	1.50	1.60	1.70
A1	0.10	0.15	0.25
A2	1.40	1.45	1.50
A3	0.60	0.65	0.70
b	0.30	0.40	0.50
c	0.15	0.20	0.25
D	9.80	9.90	10.00
E	5.80	6.00	6.20
E1	3.85	3.90	3.95
e	1.27BSC		
L	0.50	0.60	0.70
L1	1.05BSC		
θ	0°	4°	8°



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